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GROUP SAFETY PUBLICATION
PUBLICATION GROUPEE DE SÉCURITÉ

**Safety requirements for electrical equipment for measurement, control, and laboratory use –
Part 031: Safety requirements for hand-held and hand-manipulated probe assemblies for electrical test and measurement**

**Exigences de sécurité pour appareils électriques de mesurage, de régulation et de laboratoire –
Partie 031: Exigences de sécurité pour sondes équipées tenues à la main et manipulées pour mesurage et essais électriques**



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INTERNATIONAL ELECTROTECHNICAL COMMISSION

**SAFETY REQUIREMENTS FOR ELECTRICAL EQUIPMENT
FOR MEASUREMENT, CONTROL, AND LABORATORY USE –****Part 031: Safety requirements for hand-held and hand-manipulated
probe assemblies for electrical test and measurement**

FOREWORD

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IEC 61010-031 has been prepared by IEC technical committee 66: Safety of measuring, control and laboratory equipment. It is an International Standard.

It has the status of a group safety publication in accordance with IEC Guide 104.

This third edition cancels and replaces the second edition published in 2015, and Amendment 1:2018. IEC 61010-031 is a stand-alone standard.

This edition includes the following significant technical changes with respect to the previous edition:

- a) the scope has been made succinct. General information from the scope of Edition 2 has been moved to a new Clause 4. Consequently, Clause 4 to Clause 8 of Edition 2 have been renumbered. Clause 9 of Edition 2 has been deleted;

- b) in Clause 2, normative references have been dated and new normative references have been added;
- c) in 3.1.4, the definition of PROBE TIP has been modified;
- d) in 4.1, there is no longer any differentiation between high voltage and low voltage probe assemblies. Type C probe assemblies have been merged with Type B probe assemblies;
- e) in 4.1 d) "Kelvin" probes have been added to the list of probe assemblies as a new Type E and a new Figure 5;
- f) in 4.1 e), probes for voltage measurement without electrical connection to conductors have been added to the list of probe assemblies as a new Type F and a new Figure 6;
- g) in 4.2.1, spread of fire is no longer considered as a HAZARD;
- h) Subclause 4.4.2.5 from Edition 2 has been deleted;
- i) Subclause 4.4.4.3 from Edition 2 has been deleted;
- j) in 5.4.4.1 consideration has been given to SPACINGS and impedance;
- k) in 6.1.1, removable parts of PROBE TIPS which bear markings are allowed;
- l) in 6.1.5, the voltage to be marked for MEASUREMENT CATEGORIES is the AC line-to-neutral or DC voltage;
- m) in 7.4.2, requirements for unmated CONNECTORS have been modified as follows:
 - 1) Table 2 has been modified and expanded,
 - 2) a calculation method for CLEARANCES of CONNECTORS above 20 kV has been defined,
 - 3) CREEPAGE DISTANCES have been aligned with CLEARANCES
- n) in 7.4.3.1 and 7.4.3.5, requirements for IP2X PROBE TIP with retractable sleeve have been added;
- o) in 7.4.3.2, PROBE TIPS are now applicable to non-contact probe assemblies;
- p) in 7.5.2.3.2, the values of Table 5 have been modified;
- q) in 7.6.2, voltage tests of CLEARANCES are done without humidity preconditioning;
- r) pre-treatments for rigidity test from Clause 10 of Edition 2 have been moved to 9.2;
- s) Subclause 11.1 of Edition 2 has been deleted;
- t) addition of an exception for Type E probe assembly in 13.2. Removable parts of PROBE TIPS which bear markings are allowed;
- u) Figure F.1 has been modified;
- v) Annex G has been added, for determination of CLEARANCES for Table 2;
- w) Annex H has been added, covering line-to-neutral voltages for common mains supply systems.

The text of this International Standard is based on the following documents:

Draft	Report on voting
66/770/FDIS	66/771/RVD

All information on the voting for its approval can be found in the report on voting indicated in the above table.

The language used for the development of this International Standard is English.

This document was drafted in accordance with ISO/IEC Directives, Part 2, and developed in accordance with ISO/IEC Directives, Part 1 and ISO/IEC Directives, IEC Supplement, available at www.iec.ch/members_experts/refdocs. The main document types developed by IEC are described in greater detail at www.iec.ch/publications.

A list of all parts of the IEC 61010 series, published under the general title, *Safety requirements for electrical equipment for measurement, control, and laboratory use*, can be found on the IEC website.

In this document the following print types are used:

- requirements and definitions: in roman type;
- NOTES and EXAMPLES: in smaller roman type;
- *conformity and tests: in italic type;*
- terms used throughout this document which have been defined in Clause 3: SMALL ROMAN CAPITALS.

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SAFETY REQUIREMENTS FOR ELECTRICAL EQUIPMENT FOR MEASUREMENT, CONTROL, AND LABORATORY USE –

Part 031: Safety requirements for hand-held and hand-manipulated probe assemblies for electrical test and measurement

1 Scope

This part of IEC 61010 specifies safety requirements for hand-held and hand-manipulated probe assemblies for electrical test and measurement, and their related accessories. These probe assemblies are for non-contact or direct electrical connection between a part and electrical test and measurement equipment. They can be fixed to the equipment or be detachable accessories for the equipment.

This group safety publication focusing on safety essential requirements is primarily intended to be used as a product safety standard for the products mentioned in the scope, but is also intended to be used by technical committees in the preparation of publications for products similar to those mentioned in the scope of this group safety publication, in accordance with the principles laid down in IEC Guide 104 and ISO/IEC Guide 51.

One of the responsibilities of a technical committee is, wherever applicable, to make use of basic safety publications and/or group safety publications in the preparation of its publications.

2 Normative references

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60027-1:1992, *Letter symbols to be used in electrical technology – Part 1: General*
IEC 60027-1:1992/AMD1:1997
IEC 60027-1:1992/AMD2:2005

IEC 60027-2:2019, *Letter symbols to be used in electrical technology – Part 2: Telecommunications and electronics*

IEC 60027-4:2006, *Letter symbols to be used in electrical technology – Part 4: Rotating electric machines*

IEC 60529:1989, *Degrees of protection provided by enclosures (IP Code)*
IEC 60529:1989/AMD1:1999
IEC 60529:1989/AMD2:2013

IEC 61010-1:2010, *Safety requirements for electrical equipment for measurement, control, and laboratory use – Part 1: General requirements*
IEC 61010-1:2010/AMD1:2016

IEC 61180:2016, *High-voltage test techniques for low-voltage equipment – Definitions, test and procedure requirements, test equipment*